

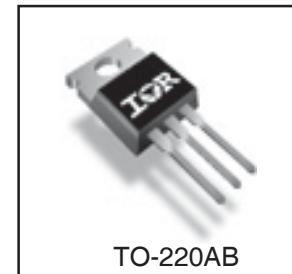
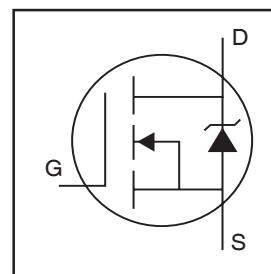
DIGITAL AUDIO MOSFET

IRFB4212PbF

Features

- Key parameters optimized for Class-D audio amplifier applications
- Low $R_{DS(ON)}$ for improved efficiency
- Low Q_G and Q_{SW} for better THD and improved efficiency
- Low Q_{RR} for better THD and lower EMI
- 175°C operating junction temperature for ruggedness
- Can deliver up to 150W per channel into 4Ω load in half-bridge topology

Key Parameters		
V_{DS}	100	V
$R_{DS(ON)}$ typ. @ 10V	72.5	mΩ
Q_g typ.	15	nC
Q_{sw} typ.	8.3	nC
$R_{G(int)}$ typ.	2.2	Ω
T_J max	175	°C



Description

This Digital Audio MOSFET is specifically designed for Class-D audio amplifier applications. This MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area. Furthermore, Gate charge, body-diode reverse recovery and internal Gate resistance are optimized to improve key Class-D audio amplifier performance factors such as efficiency, THD and EMI. Additional features of this MOSFET are 175°C operating junction temperature and repetitive avalanche capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for ClassD audio amplifier applications.

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	100	V
V_{GS}	Gate-to-Source Voltage	±20	
I_D @ $T_C = 25^\circ\text{C}$	Continuous Drain Current, V_{GS} @ 10V	18	A
I_D @ $T_C = 100^\circ\text{C}$	Continuous Drain Current, V_{GS} @ 10V	13	
I_{DM}	Pulsed Drain Current ①	57	
P_D @ $T_C = 25^\circ\text{C}$	Power Dissipation ④	60	W
P_D @ $T_C = 100^\circ\text{C}$	Power Dissipation ④	30	
	Linear Derating Factor	0.4	W/°C
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

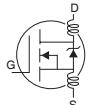
Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{θJC}$	Junction-to-Case ④	—	2.5	°C/W
$R_{θCS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	
$R_{θJA}$	Junction-to-Ambient ④	—	62	

Notes ① through ⑤ are on page 2

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.09	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	58	72.5	$\text{m}\Omega$	$V_{GS} = 10\text{V}, I_D = 13\text{A}$ ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0	—	5.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-13	—	$\text{mV}/^\circ\text{C}$	
I_{DSS}	Drain-to-Source Leakage Current	—	—	20	μA	$V_{DS} = 100\text{V}, V_{GS} = 0\text{V}$
		—	—	250	—	$V_{DS} = 100\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{GS} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200	—	$V_{GS} = -20\text{V}$
g_{fs}	Forward Transconductance	11	—	—	S	$V_{DS} = 50\text{V}, I_D = 13\text{A}$
Q_g	Total Gate Charge	—	15	23	nC	$V_{DS} = 80\text{V}$ $V_{GS} = 10\text{V}$ $I_D = 13\text{A}$ See Fig. 6 and 19
Q_{gs1}	Pre-Vth Gate-to-Source Charge	—	3.3	—		
Q_{gs2}	Post-Vth Gate-to-Source Charge	—	1.4	—		
Q_{gd}	Gate-to-Drain Charge	—	6.9	—		
Q_{godr}	Gate Charge Overdrive	—	3.4	—		
Q_{sw}	Switch Charge ($Q_{gs2} + Q_{gd}$)	—	8.3	—	ns	$V_{DD} = 50\text{V}, V_{GS} = 10\text{V}$ ③ $I_D = 13\text{A}$ $R_G = 2.5\Omega$
$R_{G(int)}$	Internal Gate Resistance	—	2.2	—		
$t_{d(on)}$	Turn-On Delay Time	—	7.7	—		
t_r	Rise Time	—	28	—		
$t_{d(off)}$	Turn-Off Delay Time	—	14	—		
t_f	Fall Time	—	3.9	—	pF	$V_{GS} = 0\text{V}$ $V_{DS} = 50\text{V}$ $f = 1.0\text{MHz}$, See Fig. 5 $V_{GS} = 0\text{V}, V_{DS} = 0\text{V to } 80\text{V}$
C_{iss}	Input Capacitance	—	550	—		
C_{oss}	Output Capacitance	—	66	—		
C_{rss}	Reverse Transfer Capacitance	—	35	—		
C_{oss}	Effective Output Capacitance	—	350	—		
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_s	Internal Source Inductance	—	7.5	—		

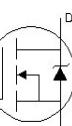


Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②	—	25	mJ
I_{AR}	Avalanche Current ⑤	See Fig. 14, 15, 17a, 17b	A	mJ
E_{AR}	Repetitive Avalanche Energy ⑤			

Diode Characteristics

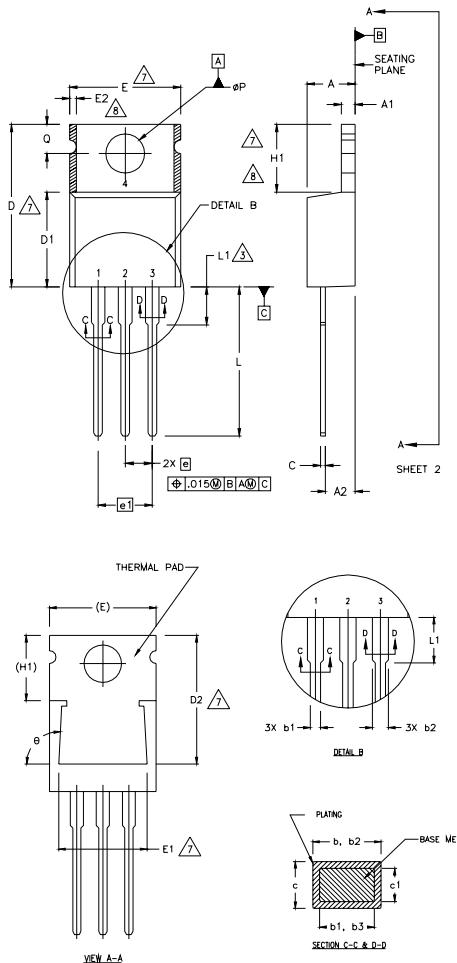
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S @ T_C = 25^\circ\text{C}$	Continuous Source Current (Body Diode)	—	—	18	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①	—	—	57		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 13\text{A}, V_{GS} = 0\text{V}$ ③
t_{rr}	Reverse Recovery Time	—	41	62	ns	$T_J = 25^\circ\text{C}, I_F = 13\text{A}$
Q_{rr}	Reverse Recovery Charge	—	69	100	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ③



Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
 ② Starting $T_J = 25^\circ\text{C}$, $L = 0.32\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 13\text{A}$.
 ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
 ④ R_θ is measured at T_J of approximately 90°C .
 ⑤ Limited by T_{jmax} . See Figs. 14, 15, 17a, 17b for repetitive avalanche information

TO-220AB Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- 3 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED ".005" (.0127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5 DIMENSION b1 & c1 APPLY TO BASE METAL ONLY.
- 6 CONTROLLING DIMENSION : INCHES.
- 7 THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E1,H1,D2 & E1
- 8 DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE

IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter

DIODES

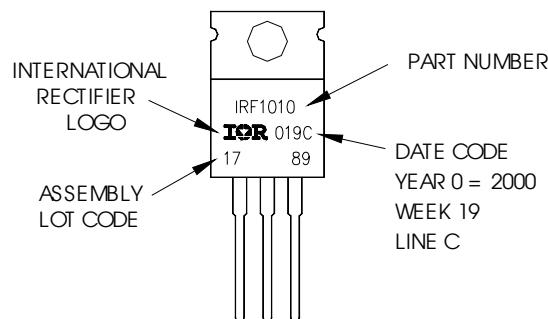
- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	3.56	4.82	.140	.190		
A1	0.51	1.40	.020	.055		
A2	2.04	2.92	.080	.115		
b	0.38	1.01	.015	.040		
b1	0.38	0.96	.015	.038	5	
b2	1.15	1.77	.045	.070		
b3	1.15	1.73	.045	.068		
c	0.36	0.61	.014	.024		
c1	0.36	0.56	.014	.022	5	
D	14.22	16.51	.560	.650	4	
D1	8.38	9.02	.330	.355	7	
D2	12.19	12.88	.480	.507	4,7	
E	9.66	10.66	.380	.420	7	
E1	8.38	8.89	.330	.350		
e	2.54 BSC		.100 BSC			
e1	5.08		.200 BSC			
H1	5.85	6.55	.230	.270	7,8	
L	12.70	14.73	.500	.580		
L1	-	6.35	-	.250	3	
ØP	3.54	4.08	.139	.161		
Q	2.54	3.42	.100	.135		
Ø	90°-93°		90°-93°			

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
LOT CODE 1789
ASSEMBLED ON WW 19, 2000
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"



TO-220AB packages are not recommended for Surface Mount Application.

Data and specifications subject to change without notice.
This product has been designed and qualified for the Industrial market.

International
IR Rectifier